

Notice of References Cited	Application/Control No. 09/759,773	Applicant(s)/Patent Under Reexamination SAVANT ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Merriam Webster's Collegiate Dictionary, 10 th Edition, 1997.
	V	American Society for Testing and Materials (ASTM) Particle (Grain) Size Distribution Scale -1980
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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